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# **Small Signal MOSFET**

20 V / -8.0 V, Complementary, +0.63 A / -0.775 A, SC-88

### **Features**

- Complementary N and P Channel Device
- Leading -8.0 V Trench for Low R<sub>DS(on)</sub> Performance
- ESD Protected Gate ESD Rating: Class 1
- SC-88 Package for Small Footprint (2 x 2 mm)
- Pb-Free Packages are Available

### **Applications**

- DC-DC Conversion
- Load/Power Switching
- Single or Dual Cell Li-Ion Battery Supplied Devices
- Cell Phones, MP3s, Digital Cameras, PDAs

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

| Parameter   |   |                       | Symbol         | Value  | Unit |
|---|---|-----------------------|----------------|--------|------|
| Drain-to-Source Voltage   | N-Ch  | $V_{DSS}$             | 20             | V      |      |
|   | P-Ch  |                       | -8.0           |        |      |
| Gate-to-Source Voltage  |   | N-Ch                  | $V_{GS}$       | ±12    | V    |
|   |   | P-Ch                  |                | ±8.0   |      |
| Continuous Drain Current  | N-Ch  | T <sub>A</sub> = 25°C | I <sub>D</sub> | 0.63   | Α    |
| – Steady State<br>(Based on R <sub>θJA</sub> )                    |   | T <sub>A</sub> = 85°C |                | 0.46   |      |
| (Basea on Heja)   | P-Ch  | T <sub>A</sub> = 25°C |                | -0.775 |      |
|   |   | T <sub>A</sub> = 85°C |                | -0.558 |      |
| Continuous Drain Current  | N-Ch  | T <sub>A</sub> = 25°C |                | 0.91   |      |
| – Steady State<br>(Based on R <sub>θJL</sub> )                    |   | T <sub>A</sub> = 85°C |                | 0.65   |      |
| (Basea on Hest)   | P-Ch  | T <sub>A</sub> = 25°C |                | -1.1   |      |
|   |   | T <sub>A</sub> = 85°C |                | -0.8   |      |
| Pulsed Drain Current  | tp ≤ 10 μs  | I <sub>DM</sub>       | ±1.2           | Α      |      |
|   | Power Dissipation – Steady State (Based on R <sub>θJA</sub> ) |                       |                | 0.27   | W    |
| (Based on $R_{\theta JA}$ )                                       |   |                       |                | 0.14   |      |
| Power Dissipation - Steady  | T <sub>A</sub> = 25°C   |                       | 0.55           |        |      |
| (Based on R <sub>θJL</sub> )                                      | T <sub>A</sub> = 85°C   |                       | 0.29           |        |      |
| Operating Junction and Sto  | T <sub>J</sub> ,  | -55 to                | °C             |        |      |
|   | T <sub>STG</sub>  | 150                   |                |        |      |
| Source Current (Body Diod   | N-Ch  | I <sub>S</sub>        | 0.63           | Α      |      |
|   |   | -0.775                |                |        |      |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) |   |                       | TL             | 260    | °C   |

### THERMAL RESISTANCE RATINGS (Note 1)

| Junction-to-Ambient            | Тур | $R_{\theta JA}$ | 400 | °C/W |
|--------------------------------|-----|-----------------|-----|------|
| <ul><li>Steady State</li></ul> | Max |                 | 460 |      |
| Junction-to-Lead (Drain)       | Тур | $R_{\theta JL}$ | 194 |      |
| <ul><li>Steady State</li></ul> | Max |                 | 226 |      |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

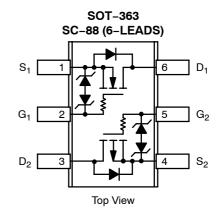
1. Surface mounted on FR4 board using 1 oz Cu area = 0.9523 in sq.



### ON Semiconductor®

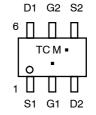
### http://onsemi.com

| V <sub>(BR)DSS</sub> | R <sub>DS(on)</sub> TYP | I <sub>D</sub> Max |
|----------------------|-------------------------|--------------------|
| N-Ch 20 V            | 0.29 $\Omega$ @ 4.5 $V$ |                    |
|                      | 0.36 Ω @ 2.5 V          | 0.63 A             |
|                      | 0.22 Ω @ -4.5 V         |                    |
| P-Ch -8.0 V          | 0.32 Ω @ -2.5 V         | -0.775 A           |
|                      | 0.51 Ω @ –1.8 V         |                    |



### **MARKING DIAGRAM & PIN ASSIGNMENT**





TC = Device Code = Date Code = Pb-Free Package

(Note: Microdot may be in either location)

### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 7 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

| Parameter  | Symbol                | N/P                       | Test Condition   |                           | Min   | Тур   | Max   | Units    |
|--|-----------------------|---------------------------|--|---------------------------|-------|-------|-------|----------|
| OFF CHARACTERISTICS  | •                     | -                         |  |                           |       | -     | ā.    | -        |
| Drain-to-Source  | V <sub>(BR)DSS</sub>  | N                         |  | I <sub>D</sub> = 250 μA   | 20    | 27    |       | V        |
| Breakdown Voltage  | (511)500              | Р                         | $V_{GS} = 0 V$   | $I_D = -250 \mu A$        | -8.0  | -10.5 |       |          |
| Drain-to-Source Breakdown  | V <sub>(BR)DSS</sub>  | N                         |  | D (                       |       | 22    |       | mV/ °C   |
| Voltage Temperature Coefficient  | /T <sub>J</sub>       | Р                         |  |                           |       | -6.0  |       |          |
| Zero Gate Voltage Drain Cur-   | I <sub>DSS</sub>      | N                         | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 16 V  | T 05.00                   |       |       | 1.0   | μΑ       |
| rent   |                       | Р                         | $V_{GS} = 0 \text{ V}, V_{DS} = -6.4 \text{ V}$  | T <sub>J</sub> = 25 °C    |       |       | 1.0   | 1        |
| Gate-to-Source   | I <sub>GSS</sub>      | N                         |  | V <sub>GS</sub> = ±12 V   |       |       | 10    | μΑ       |
| Leakage Current  |                       | Р                         | $V_{DS} = 0 V$   | V <sub>GS</sub> = ±8.0    |       |       | 10    | 1        |
| ON CHARACTERISTICS (Note 2   | 2)                    |                           |  |                           |       |       |       |          |
| Gate Threshold Voltage   | V <sub>GS(TH)</sub>   | N                         | \/aa - \/-a  | $I_D = 250  \mu A$        | 0.6   | 0.92  | 1.5   | V        |
|  |                       | Р                         | $V_{GS} = V_{DS}$  | $I_D = -250 \mu A$        | -0.45 | -0.83 | -1.0  | 1        |
| Gate Threshold   | V <sub>GS(TH)</sub> / | N                         |  |                           |       | -2.1  |       | -mV/ °C  |
| Temperature Coefficient  | ТЈ                    | Р                         |  |                           |       | 2.2   |       | 1        |
| Drain-to-Source On Resist-   | R <sub>DS(on)</sub>   | N                         | V <sub>GS</sub> = 4.5 V I <sub>D</sub> = 0.63 A  |                           |       | 0.29  | 0.375 | Ω        |
| ance   |                       | Р                         | V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -0.57 A   |                           |       | 0.22  | 0.30  | 1        |
|  |                       | N                         | $V_{GS} = 2.5 \text{ V}, I_D =$  | 0.40 A                    |       | 0.36  | 0.445 | 1        |
|  |                       | Р                         | $V_{GS} = -2.5 \text{ V, } I_D = -0.48 \text{ A}$  |                           |       | 0.32  | 0.46  | 7        |
|  |                       | Р                         | $V_{GS} = -1.8 \text{ V}, I_D =$   | -0.20 A                   |       | 0.51  | 0.90  | 1        |
| Forward Transconductance   | 9FS                   | N                         | V <sub>DS</sub> = 4.0 V I <sub>D</sub> = 0   | 0.63 A                    |       | 2.0   |       | S        |
|  |                       | Р                         | $V_{DS} = -4.0 \text{ V}, I_{D} = -4.0 \text{ V}$  | -0.57 A                   |       | 2.0   |       | 1        |
| CHARGES AND CAPACITANCE  | S                     |                           |  |                           |       | •     | •     |          |
| Input Capacitance  | C <sub>ISS</sub>      | N                         |  | V <sub>DS</sub> = 20 V    |       | 33    | 46    | pF       |
| •  | .55                   | Р                         |  | $V_{DS} = -8.0V$          |       | 160   | 225   | 1        |
| Output Capacitance   | C <sub>OSS</sub>      | N                         |  | V <sub>DS</sub> = 20 V    |       | 13    | 22    | 1        |
|  | 000                   | Р                         | $f = 1 MHz, V_{GS} = 0 V$  | $V_{DS} = -8.0 \text{ V}$ |       | 38    | 55    | 1        |
| Reverse Transfer Capacitance   | C <sub>RSS</sub>      | N                         |  | V <sub>DS</sub> = 20 V    |       | 2.8   | 5.0   | 1        |
| •  |                       | $V_{DS} = -8.0 \text{ V}$ |  | 28                        | 40    | 1     |       |          |
| Total Gate Charge  | Q <sub>G(TOT)</sub>   | N                         | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10 V  |                           |       | 1.3   | 3.0   | nC       |
| Ğ  | G(101)                | Р                         | $V_{GS} = -4.5 \text{ V}, V_{DS} = -5.0 \text{ V}, I_{D} = -0.6 \text{ A}$                       |                           |       | 2.2   | 4.0   | 1        |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>    | N                         | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10 V  |                           |       | 0.1   |       | 1        |
| 3  | ·G(111)               | Р                         | $V_{GS} = -4.5 \text{ V}, V_{DS} = -5.0$   |                           |       | 0.1   |       | 1        |
| Gate-to-Source Charge  | Q <sub>GS</sub>       | N                         | $V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V}$  |                           |       | 0.2   |       | 1        |
| J  | 40                    | Р                         | $V_{GS} = -4.5 \text{ V}, V_{DS} = -5.0$   |                           |       | 0.5   |       | 1        |
| Gate-to-Drain Charge   | Q <sub>GD</sub>       | N                         | $V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V}$  |                           |       | 0.4   |       |          |
|  | - GD                  | P                         | $V_{GS} = -4.5 \text{ V}, V_{DS} = -5.0$   |                           |       | 0.5   |       | 1        |
| SWITCHING CHARACTERISTIC   | S (Note 3)            |                           | <u> </u>   | , D                       |       |       |       | 1        |
| Turn-On Delay Time   | t <sub>d(ON)</sub>    | N                         |  |                           |       | 0.083 |       | μS       |
| Rise Time  | t <sub>r</sub>        |                           | V <sub>GS</sub> = 4.5 V, V <sub>DD</sub> =   | = 10 V.                   |       | 0.227 |       | 1        |
| Turn-Off Delay Time  | t <sub>d(OFF)</sub>   | 1                         | $I_D = 0.5 \text{ A}, R_G =$   | 20 Ω                      |       | 0.786 |       | 1        |
| Fall Time  | t <sub>f</sub>        | 1                         | _  |                           |       | 0.506 |       | 1        |
| Turn-On Delay Time   | t <sub>d(ON)</sub>    | Р                         |  |                           |       | 0.013 |       | 1        |
| Rise Time  | t <sub>r</sub>        | 1                         | $V_{GS} = -4.5 \text{ V}, V_{DD} = -4.0 \text{ V},$ $I_{D} = -0.5 \text{ A}, R_{G} = 8.0 \Omega$ |                           |       | 0.023 |       | 1        |
| Turn-Off Delay Time  | t <sub>d(OFF)</sub>   | 1                         |  |                           |       | 0.050 |       | 1        |
| Fall Time  | t <sub>f</sub>        | 1                         |  |                           |       | 0.036 |       | 1        |
| DRAIN-SOURCE DIODE CHAR  |                       | cs                        |  |                           |       |       |       | 1        |
| Forward Diode Voltage  | V <sub>SD</sub>       | N                         | –  | I <sub>S</sub> = 0.23 A   |       | 0.76  | 1.1   | V        |
|  | - 30                  | P                         | $V_{GS} = 0 \text{ V}, T_J = 25^{\circ}\text{C}$   | $I_S = -0.23 \text{ A}$   |       | 0.76  | 1.1   | 1        |
|  |                       | N                         |  | $I_S = 0.23 \text{ A}$    |       | 0.63  | ···   | 1        |
|  |                       | P                         | $V_{GS} = 0 \text{ V}, T_{J} = 125^{\circ}\text{C}$  | $I_S = -0.23 \text{ A}$   |       | 0.63  |       | 1        |
| Reverse Recovery Time  | t <sub>RR</sub>       | N                         | V <sub>GS</sub> = 0 V,   | $I_S = 0.23 \text{ A}$    |       | 0.410 |       | μs       |
| The state of the s | -HH                   | P                         | $V_{GS} = 0 \text{ V},$ $d_{IS}/d_t = 90 \text{ A}/\mu\text{s}$                                  | $I_S = -0.23 \text{ A}$   |       | 0.078 |       | ا ا      |
|  |                       |                           | -10/-1 00/1/μο   | 15 - 0.20 A               |       | 0.070 |       | <u> </u> |

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

### $\textbf{TYPICAL N-CHANNEL PERFORMANCE CURVES} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

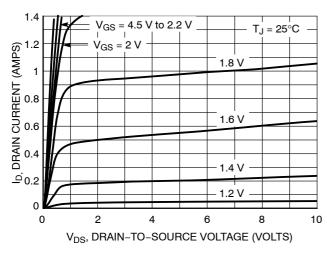


Figure 1. On-Region Characteristics

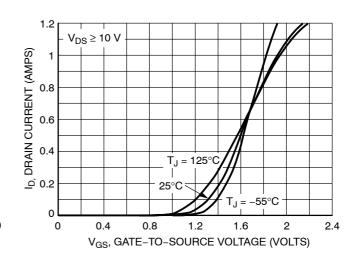


Figure 2. Transfer Characteristics

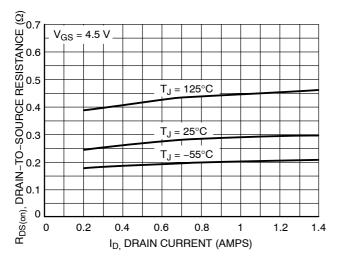


Figure 3. On-Resistance vs. Drain Current and Temperature

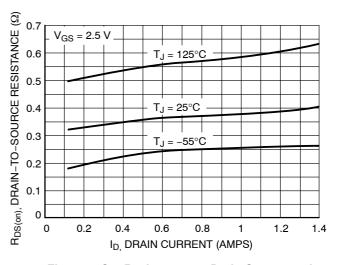


Figure 4. On–Resistance vs. Drain Current and Temperature

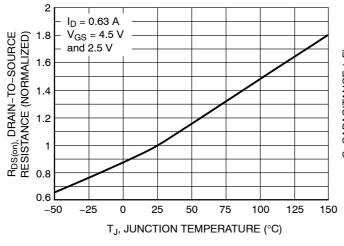


Figure 5. On–Resistance Variation with Temperature

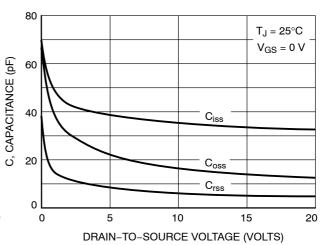


Figure 6. Capacitance Variation

## TYPICAL N-CHANNEL PERFORMANCE CURVES ( $T_J = 25$ °C unless otherwise noted)

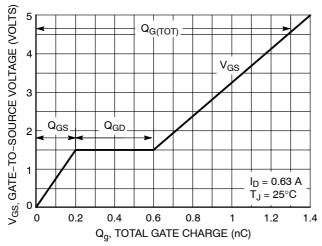


Figure 7. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

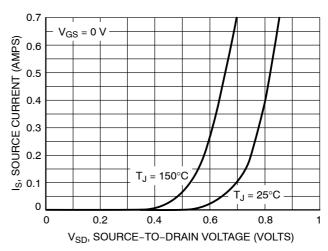


Figure 8. Diode Forward Voltage vs. Current

### TYPICAL P-CHANNEL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

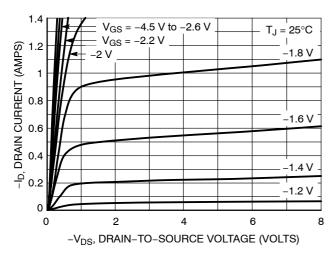


Figure 9. On-Region Characteristics

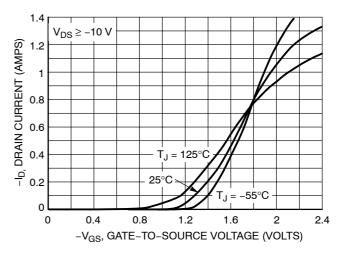


Figure 10. Transfer Characteristics

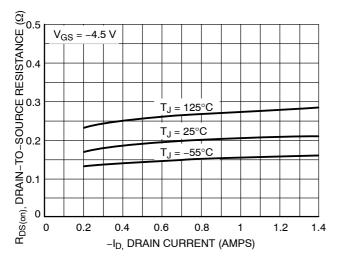


Figure 11. On-Resistance vs. Drain Current and Temperature

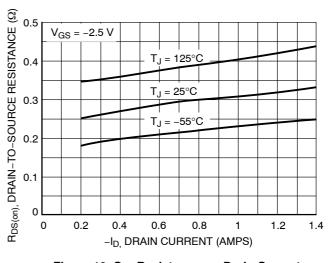


Figure 12. On-Resistance vs. Drain Current and Temperature

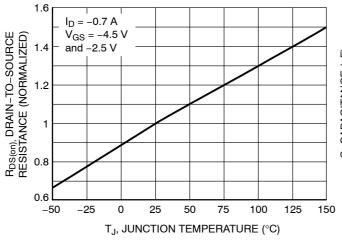


Figure 13. On–Resistance Variation with Temperature

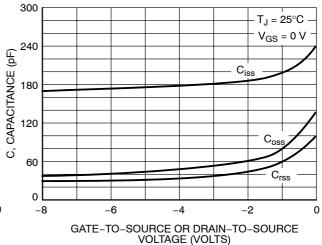


Figure 14. Capacitance Variation

## TYPICAL P-CHANNEL PERFORMANCE CURVES ( $T_J = 25$ °C unless otherwise noted)

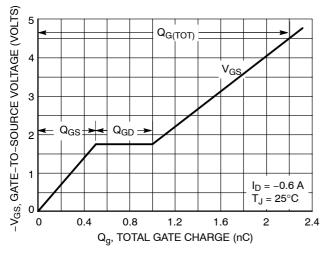


Figure 15. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

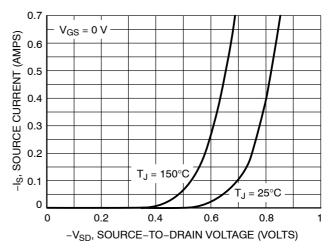


Figure 16. Diode Forward Voltage vs. Current

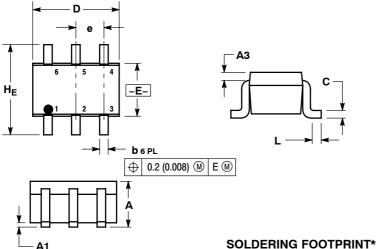
### **ORDERING INFORMATION**

| Device       | Package              | Shipping <sup>†</sup> |
|--------------|----------------------|-----------------------|
| NTJD4105CT1  | SOT-363              | 3000 / Tape & Reel    |
| NTJD4105CT1G | SOT-363<br>(Pb-Free) | 3000 / Tape & Reel    |
| NTJD4105CT2  | SOT-363              | 3000 / Tape & Reel    |
| NTJD4105CT2G | SOT-363<br>(Pb-Free) | 3000 / Tape & Reel    |
| NTJD4105CT4  | SOT-363              | 10,000 / Tape & Reel  |
| NTJD4105CT4G | SOT-363<br>(Pb-Free) | 10,000 / Tape & Reel  |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### PACKAGE DIMENSIONS

### SC-88/SC70-6/SOT-363 CASE 419B-02 **ISSUE W**



#### NOTES

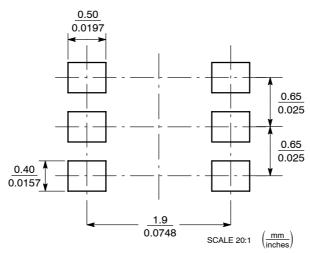
- DIMENSIONING AND TOLERANCING PER ANSI
- Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.
- 419B-01 OBSOLETE, NEW STANDARD 419B-02.

|     | MIL  | LIMETE  | ERS  | INCHES    |         |       |  |
|-----|------|---------|------|-----------|---------|-------|--|
| DIM | MIN  | MIN NOM |      | MIN       | NOM     | MAX   |  |
| Α   | 0.80 | 0.95    | 1.10 | 0.031     | 0.037   | 0.043 |  |
| A1  | 0.00 | 0.05    | 0.10 | 0.000     | 0.002   | 0.004 |  |
| А3  |      | 0.20 RE | F    | 0.008 REF |         |       |  |
| b   | 0.10 | 0.21    | 0.30 | 0.004     | 0.008   | 0.012 |  |
| C   | 0.10 | 0.14    | 0.25 | 0.004     | 0.005   | 0.010 |  |
| D   | 1.80 | 2.00    | 2.20 | 0.070     | 0.078   | 0.086 |  |
| Е   | 1.15 | 1.25    | 1.35 | 0.045     | 0.049   | 0.053 |  |
| е   | (    | 0.65 BS | С    | 0         | .026 BS | С     |  |
| L   | 0.10 | 0.20    | 0.30 | 0.004     | 0.008   | 0.012 |  |
| He  | 2.00 | 2.10    | 2.20 | 0.078     | 0.082   | 0.086 |  |

#### STYLE 26:

- PIN 1. SOURCE 1
  - 2. GATE 1
  - 3. DRAIN 2 4. SOURCE 2

  - 5. GATE 2 6. DRAIN 1



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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